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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/540,980	08/09/2006	Shinichi Terada	2691-000022/US	9530
	7590 11/04/200 CKEY & PIERCE, P.L	EXAMINER		
P.O. BOX 8910	·	KAO, CHIH CHENG G		
RESTON, VA 20195			ART UNIT	PAPER NUMBER
		2882		
			MAIL DATE	DELIVERY MODE
			11/04/2008	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

## Advisory Action Before the Filing of an Appeal Brief

Application No.	Applicant(s)	
10/540,980	TERADA, SHINICHI	
Examiner	Art Unit	

	Chin-Cheng Glen Kao	2882	
The MAILING DATE of this communication appe	ars on the cover sheet with the o	correspondence add	ress
THE REPLY FILED <u>15 October 2008</u> FAILS TO PLACE THIS A	PPLICATION IN CONDITION FOR	R ALLOWANCE.	
1.  The reply was filed after a final rejection, but prior to or on application, applicant must timely file one of the following application in condition for allowance; (2) a Notice of Appetor Continued Examination (RCE) in compliance with 37 C periods:	replies: (1) an amendment, affidavi eal (with appeal fee) in compliance	t, or other evidence, w with 37 CFR 41.31; or	hich places the (3) a Request
<ul> <li>a) The period for reply expires 3 months from the mailing date</li> <li>b) The period for reply expires on: (1) the mailing date of this A</li> </ul>	dvisory Action, or (2) the date set forth	•	
no event, however, will the statutory period for reply expire la Examiner Note: If box 1 is checked, check either box (a) or ( MONTHS OF THE FINAL REJECTION. See MPEP 706.07(t	b). ONLY CHECK BOX (b) WHEN THE	•	
Extensions of time may be obtained under 37 CFR 1.136(a). The date of have been filed is the date for purposes of determining the period of extunder 37 CFR 1.17(a) is calculated from: (1) the expiration date of the set forth in (b) above, if checked. Any reply received by the Office later may reduce any earned patent term adjustment. See 37 CFR 1.704(b). NOTICE OF APPEAL	on which the petition under 37 CFR 1.1 ension and the corresponding amount of hortened statutory period for reply origi	of the fee. The appropria nally set in the final Offic	ate extension fee e action; or (2) as
2. ☐ The Notice of Appeal was filed on A brief in comp	liance with 37 CER 41 37 must be t	filed within two months	s of the date of
filing the Notice of Appeal (37 CFR 41.37(a)), or any exter Notice of Appeal has been filed, any reply must be filed wi	nsion thereof (37 CFR 41.37(e)), to	avoid dismissal of the	
AMENDMENTS			
<ol> <li>The proposed amendment(s) filed after a final rejection, be (a) They raise new issues that would require further core (b) They raise the issue of new matter (see NOTE below</li> </ol>	nsideration and/or search (see NO	<del></del>	cause
(c) They have not deemed to place the application in bett appeal; and/or	•	lucing or simplifying tl	ne issues for
(d) ☐ They present additional claims without canceling a converse NOTE: (See 37 CFR 1.116 and 41.33(a)).	corresponding number of finally reje	ected claims.	
4. The amendments are not in compliance with 37 CFR 1.12	21 See attached Notice of Non-Co	mpliant Amendment (	PTOL-324)
5. Applicant's reply has overcome the following rejection(s):		mphane / mioriamione (i	. 02 02 1/1
<ol> <li>Newly proposed or amended claim(s) would be all non-allowable claim(s).</li> </ol>		imely filed amendmer	nt canceling the
7.  For purposes of appeal, the proposed amendment(s): a) [ how the new or amended claims would be rejected is prov The status of the claim(s) is (or will be) as follows: Claim(s) allowed: Claim(s) objected to: 12 and 16. Claim(s) rejected: 9-11 and 13-15. Claim(s) withdrawn from consideration:		l be entered and an e	xplanation of
AFFIDAVIT OR OTHER EVIDENCE			
8. The affidavit or other evidence filed after a final action, but because applicant failed to provide a showing of good and was not earlier presented. See 37 CFR 1.116(e).			
9. The affidavit or other evidence filed after the date of filing entered because the affidavit or other evidence failed to o showing a good and sufficient reasons why it is necessary	vercome <u>all</u> rejections under appea	ıl and/or appellant fail:	s to provide a
10. ☐ The affidavit or other evidence is entered. An explanation REQUEST FOR RECONSIDERATION/OTHER	n of the status of the claims after er	ntry is below or attach	ed.
<ol> <li>The request for reconsideration has been considered but <u>See Continuation Sheet.</u></li> </ol>	t does NOT place the application in	condition for allowan	ce because:
<ul><li>12. ☐ Note the attached Information <i>Disclosure Statement</i>(s). (</li><li>13. ☐ Other:</li></ul>	PTO/SB/08) Paper No(s)		
	/Chih-Cheng Glen Kao/ Primary Examiner, Art U	nit 2882	

Continuation of 11. does NOT place the application in condition for allowance because:

Regarding at least claims 9 and 15, Applicant argues that Koppel et al. fails to disclose irradiating the insulator film with X-rays from the insulator film's surface side at an incident angle which is set to be larger than a total-reflection critical angle of the insulator, but less than 1.3 times a total-reflection critical angle of the substrate. The Examiner disagrees. As seen in Figure 3, Koppel et al. shows two critical angles 306 and 308, which correspond to the critical angle of the insulator (fig. 3, #306) and the critical angle of the substrate (fig. 3, #308). As seen in Figure 3, the reflection angle increases as the incident angle is changed (fig. 4, #406; and col. 4, lines 7-25) as further explained by Koppel et al. Since the angle of incidence goes through a range of angles, as evidenced by the graph in Figure 3, Koppel et al. will necessarily irradiate the insulator film with X-rays from the insulator film's surface side at an incident angle which is set to be larger than a total-reflection critical angle of the insulator, but less than 1.3 times a total-reflection critical angle of the substrate, at some point in that graph of Figure 3. Therefore, Koppel et al. necessarily discloses that portion of the claim.

Furthermore, with regards to claim 15, Applicant submits that there is an inconsistent statement in suggesting that Koppel both does and does not disclose a point focus X-ray source. The Examiner disagrees with this contention. As seen on page 13 of the Office Action mailed July 7, 2008, the Examiner stated that Koppel et al. (i.e., US 6507634) does not disclose a point focus X-ray source. The Examiner also stated that Koppel (i.e., US 5619548) does disclose a point focus X-ray source. However, the Examiner never stated that Koppel (i.e., US 5619548) discloses a point focus X-ray source. Therefore, the Examiner only stated that Koppel (i.e., US 5619548) discloses a point focus X-ray source.

Applicant also argues that Koppel only teaches an X-ray source, not a point focus X-ray source. The Examiner disagrees. As seen in Figure 4 of Koppel, the X-ray beams of the X-ray source (fig. 4, #31) start from a point focus at the X-ray source. Therefore, Koppel does disclose a point focus X-ray source.

In conclusion, Applicant's arguments are not persuasive, and the respective claims remain rejected.